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10/680,509	HSIEH ET AL.	
Examiner	Art Unit	
Vikki H. Trinh	2814	

SEARCHED					
Class	Subclass	Date	Examiner		
438	107, 409, 455, 458	4/27/2005	VΤ		

INTERFERENCE SEARCHED					
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
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